

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination CHEN, ET AL. <i>OS</i>	
		Examiner Cheukfan Lee	Art Unit 2622	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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	B	US-6,163,388	12-2000	Lee et al.	358/488
	C	US-5,900,950	05-1999	Hsu, Adolf T. R.	358/497
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	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

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	U	
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